



Substitute Form PTO-1449 (Modified)  <b>Information Disclosure Statement by Applicant</b> (Use several sheets if necessary)  (37 CFR §1.98(b))	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. <b>12732-075002</b>	Application No. <b>10/728,903</b>
	Applicant <b>Akira Ishikawa</b>		
	Filing Date <b>December 8, 2003</b>	Group Art Unit <b>2826</b>	

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
<b>TE</b>	AA	5,166,556	11/24/1992	Hsu et al.	_____	_____	01/22/1991
	AB	5,206,749	04/27/1993	Zavracky et al.	_____	_____	12/31/1990
	AC	5,256,562	10/26/1993	Vu et al.	_____	_____	11/04/1992
	AD	5,258,325	11/02/1993	Spitzer et al.	_____	_____	02/13/1992
	AE	5,317,236	05/31/1994	Zavracky et al.	_____	_____	12/31/1991
	AF	5,331,149	07/19/1994	Spitzer et al.	_____	_____	12/04/1992
	AG	5,376,561	12/27/1994	Vu et al.	_____	_____	04/24/1992
	AH	5,376,979	12/27/1994	Zavracky et al.	_____	_____	08/13/1993
	AI	5,396,304	03/07/1995	Salerno et al.	_____	_____	02/10/1993
	AJ	5,444,557	08/22/1995	Spitzer et al.	_____	_____	09/11/1992
	AK	5,467,154	11/14/1995	Gale et al.	_____	_____	02/10/1993
	AL	5,475,514	12/12/1995	Salerno et al.	_____	_____	08/11/1994
	AM	5,581,385	12/03/1996	Spitzer et al.	_____	_____	03/24/1995
	AN	5,661,371	08/26/1997	Salerno et al.	_____	_____	03/04/1996
	AO	5,666,175	09/09/1997	Spitzer et al.	_____	_____	08/29/1994
	AP	5,692,820	12/02/1997	Gale et al.	_____	_____	01/27/1995
	AQ	5,743,614	04/28/1998	Salerno et al.	_____	_____	06/07/1995
	AR	5,751,261	05/12/1998	Zavracky et al.	_____	_____	08/13/1993
	AS	5,861,929	01/19/1999	Spitzer	_____	_____	11/04/1992
	AT	6,022,792	02/08/2000	Ishii et al.	_____	_____	03/12/1997
	AU	6,043,800	03/28/2000	Spitzer et al.	_____	_____	06/06/1995
	AV	6,072,445	06/06/2000	Spitzer et al.	_____	_____	06/07/1995
	AW	6,320,568 B1	11/20/2001	Zavracky	_____	_____	12/27/1994
<b>TE</b>	AX	6,424,020 B1	07/23/2002	Vu et al.	_____	_____	12/29/1997

Foreign Patent Documents or Published Foreign Patent Applications								
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No

Examiner Signature 	Date Considered <b>8/15/05</b>
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	



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	Applicant <b>Akira Ishikawa</b>		
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							Yes	No
	AY							
	AZ							
	AAA							
	ABB							
	ACC							

Other Documents (include Author, Title, Date, and Place of Publication)		
Examiner Initial	Desig. ID	Document
<b>TG</b>	ADD	Australian Patent Office Communication – Search Report (Singapore Patent Application No. 200105539-1) dated September 30, 2004; 4 pages
	AEE	
	AFF	
	AGG	

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		Applicant <b>Akira Ishikawa</b>	
		Filing Date <b>December 3, 2003</b>	Group Art Unit <b>1826</b>

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
<u>D</u>	AA	5,376,561	12/27/1994	Vu et al.	_____	_____	04/24/1992
	AB	5,643,826	07/01/1997	Ohtani et al.	_____	_____	10/25/1994
	AC	5,757,456	05/26/1998	Yamazaki et al.	_____	_____	03/08/1996
	AD	5,766,977	06/16/1998	Yamazaki	_____	_____	03/27/1996
	AE	5,834,327	11/10/1998	Yamazaki et al.	_____	_____	03/18/1996
	AF	6,127,199	10/03/2000	Inoue et al.	_____	_____	07/10/1998
	AG	6,133,626	10/17/2000	Hawke et al.	_____	_____	09/24/1998
	AH	6,258,623	07/10/2001	Moden et al.	_____	_____	07/08/1999
	AI	6,317,175	12/2001	Salerno et al.	<del>349</del>	_____	
	AJ	6,022,792	02/2000	Ishii et al.	<del>29</del>	_____	
	AK	6,423,614	07/23/02	Doyle	<del>438</del>	_____	
	AL	5,757,456	05/26/1998	Yamazaki et al.	_____	_____	03/08/1996
<u>D</u>	AM	5,953,595	09/14/1999	Gosain et al.	_____	_____	09/27/1996

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